Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,108	DAI, KEN-SHWO	
Examiner	Art Unit	
Hong Sang	1643	

	SEARCHED		
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEAR)
	DATE	EXMR
STIC sequence search -enclosed	2/9/2006	H.S.
PALM inventor search	2/13/2006	H.S.
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